## Notice of References Cited 10/743,631 Examiner Huan H. Tran Reexamination BURDENKO, MICHAEL N. Page 1 of 1

Application/Control No.

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	Ι	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02-24176	01-1990	Japan	Sato	400/618
	0	JP 01-031663	02-1989	Japan	Saito et al	400/625
	Р	JP 2001-071569	03-2001	Japan	Mori	B41J003/60
	Q					
	R					
	S					
	Т				·	

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	·
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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